

Notic of Referenc s Cited

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

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Art Unit

2812

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-US006287893B1	09-2001	Elenius et al.	438/108
	B	US-US006413868B1	07-2002	Bartush et al.	438/690
	C	US-US 20020140069A1	10-2002	Lee et al.	257/678
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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